

# International Rectifier

HEXFET® Power MOSFET

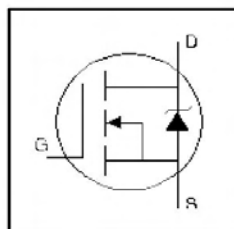
## IRL630PbF

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- $R_{DS(on)}$  Specified at  $V_{GS} = 4V \text{ \& } 5V$
- 150°C Operating Temperature
- Fast Switching
- Ease of paralleling
- Lead-Free

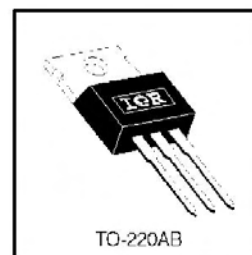
### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



|                           |
|---------------------------|
| $V_{DSS} = 200V$          |
| $R_{DS(on)} = 0.40\Omega$ |
| $I_D = 9.0A$              |



### Absolute Maximum Ratings

|                           | Parameter                                 | Max.               | Units |
|---------------------------|-------------------------------------------|--------------------|-------|
| $I_D @ T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ 5.0V$ | 9.0                | A     |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 5.0V$ | 5.7                |       |
| $I_{DM}$                  | Pulsed Drain Current ①                    | 36                 |       |
| $P_D @ T_C = 25^\circ C$  | Power Dissipation                         | 74                 | W     |
|                           | Linear Derating Factor                    | 0.59               | W/°C  |
| $V_{GS}$                  | Gate-to-Source Voltage                    | $\pm 10$           | V     |
| $E_{AS}$                  | Single Pulse Avalanche Energy ②           | 250                | mJ    |
| $I_{AR}$                  | Avalanche Current ①                       | 9.0                | A     |
| $E_{AR}$                  | Repetitive Avalanche Energy ①             | 7.4                | mJ    |
| dv/dt                     | Peak Diode Recovery dv/dt ③               | 5.0                | V/ns  |
| $T_J$                     | Operating Junction and                    | -55 to + 150       | °C    |
| $T_{STG}$                 | Storage Temperature Range                 |                    |       |
|                           | Soldering Temperature, for 10 seconds     |                    |       |
|                           | Mounting torque, 6-32 or M3 screw.        | 10 lbf•in (1.1N•m) |       |

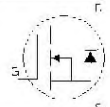
### Thermal Resistance

|                 | Parameter                           | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | —    | 1.7  | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | —    | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | —    | 62   |       |

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units        | Conditions                                                         |
|---------------------------------|--------------------------------------|------|------|------|--------------|--------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 200  | —    | —    | V            | $V_{GS} = 0V, I_D = 250\mu A$                                      |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.27 | —    | $V/^\circ C$ | Reference to $25^\circ C, I_D = 1mA$                               |
| $R_{DS(ON)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.40 | $\Omega$     | $V_{GS} = 5.0V, I_D = 5.4A$ ②                                      |
|                                 |                                      | —    | —    | 0.50 |              | $V_{GS} = 4.0V, I_D = 4.5A$ ②                                      |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 1.0  | —    | 2.0  | V            | $V_{DS} = V_{GS}, I_D = 250\mu A$                                  |
| $g_{fs}$                        | Forward Transconductance             | 4.8  | —    | —    | S            | $V_{DS} = 50V, I_D = 5.4A$                                         |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$      | $V_{DS} = 200V, V_{GS} = 0V$                                       |
|                                 |                                      | —    | —    | 250  |              | $V_{DS} = 160V, V_{GS} = 0V, T_J = 125^\circ C$                    |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA           | $V_{GS} = 10V$                                                     |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |              | $V_{GS} = -10V$                                                    |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 40   | nC           | $I_D = 9.0A$                                                       |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 5.5  |              | $V_{DS} = 160V$                                                    |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 24   |              | $V_{GS} = 10V$ , See Fig. 6 and 13 ③                               |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 8.0  | —    | ns           | $V_{DD} = 100V$                                                    |
| $t_r$                           | Rise Time                            | —    | 57   | —    |              | $I_D = 9.0A$                                                       |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 38   | —    |              | $R_G = 6.0\Omega$                                                  |
| $t_f$                           | Fall Time                            | —    | 33   | —    |              | $R_D = 11\Omega$ , See Fig. 10 ④                                   |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH           | Between lead, 6mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |              |                                                                    |
| $C_{iss}$                       | Input Capacitance                    | —    | 1100 | —    | pF           | $V_{GS} = 0V$                                                      |
| $C_{oss}$                       | Output Capacitance                   | —    | 220  | —    |              | $V_{DS} = 25V$                                                     |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 70   | —    |              | $f = 1.0MHz$ , See Fig. 5                                          |

## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min.                                                                        | Typ. | Max. | Units   | Conditions                                                                                                                                           |
|----------|----------------------------------------|-----------------------------------------------------------------------------|------|------|---------|------------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                           | —    | 9.0  | A       | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                           | —    | 36   |         |                                                                                                                                                      |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                           | —    | 2.0  | V       | $T_J = 25^\circ C, I_S = 9.0A, V_{GS} = 0V$ ④                                                                                                        |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                           | 230  | 350  | ns      | $T_J = 25^\circ C, I_F = 9.0A$                                                                                                                       |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                           | 1.7  | 2.6  | $\mu C$ | $di/dt = 100A/\mu s$ ④                                                                                                                               |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |         |                                                                                                                                                      |

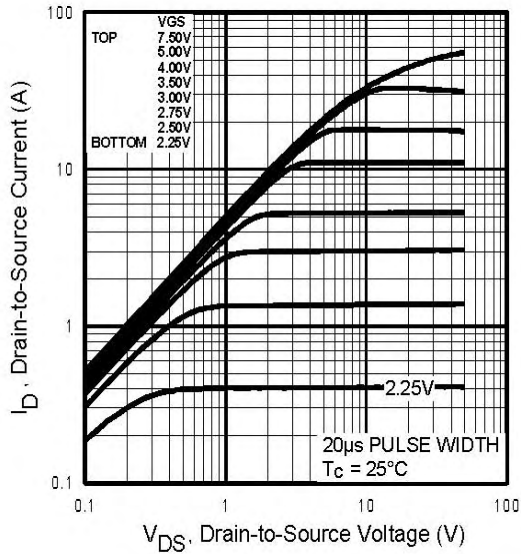
### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

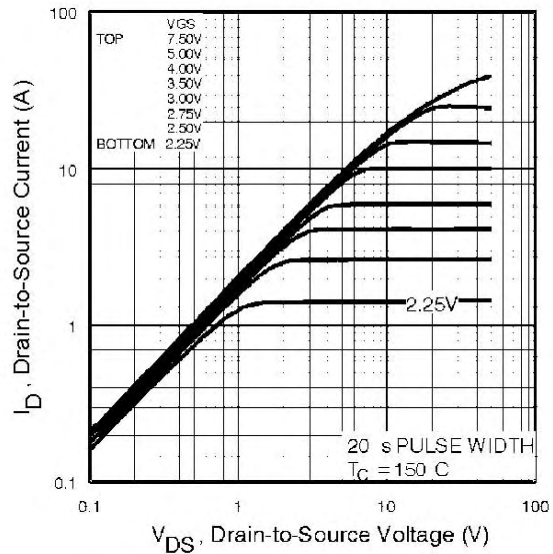
③  $I_{SD} \leq 9.0A, di/dt \leq 120A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ C$

②  $V_{DD} = 25V$ , starting  $T_J = 25^\circ C, L = 4.6mH, R_G = 25\Omega, I_{AS} = 9.0A$ . (See Figure 12)

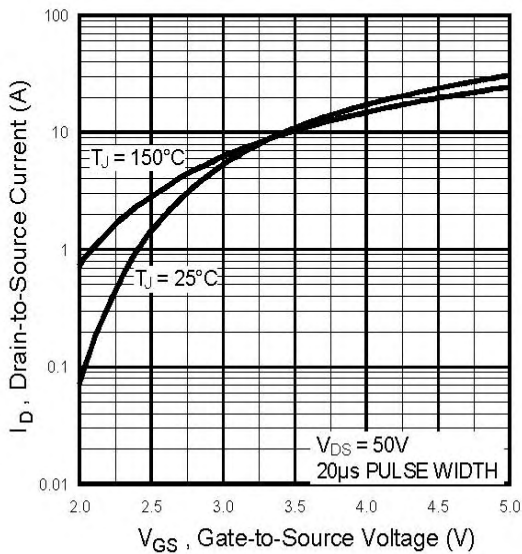
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



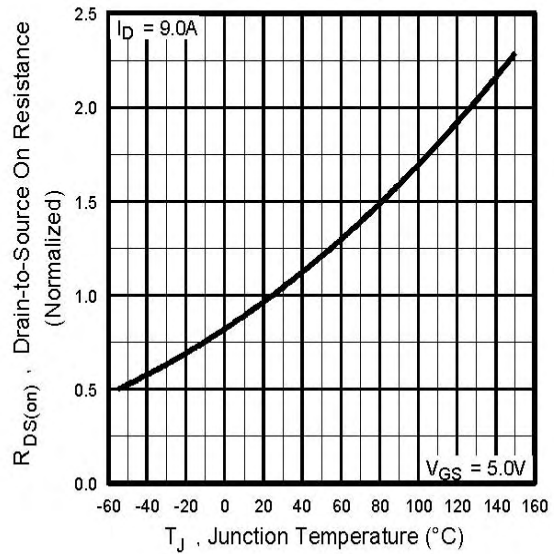
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C = 150^\circ\text{C}$



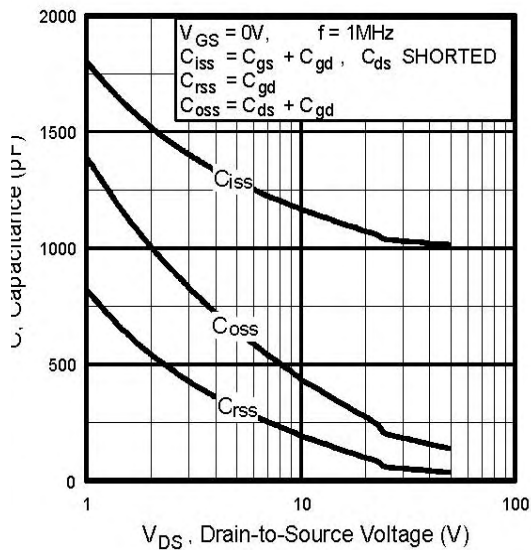
**Fig 3.** Typical Transfer Characteristics



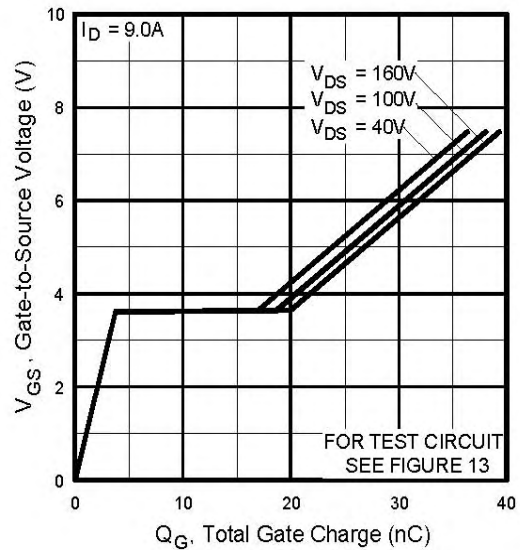
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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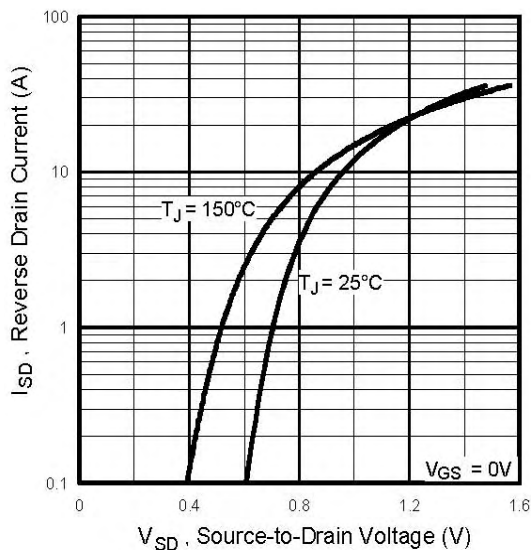
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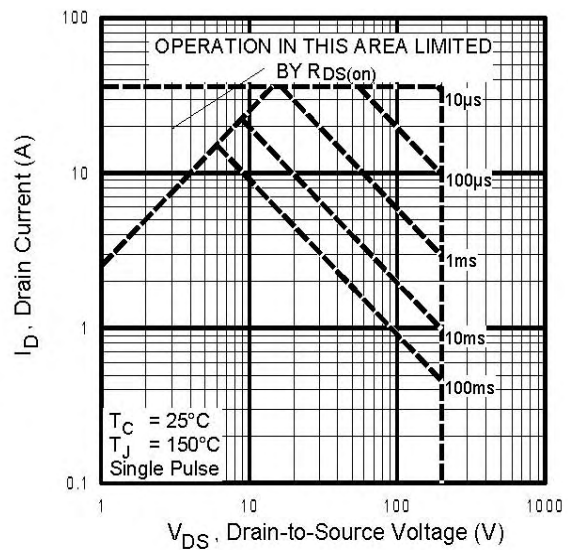
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



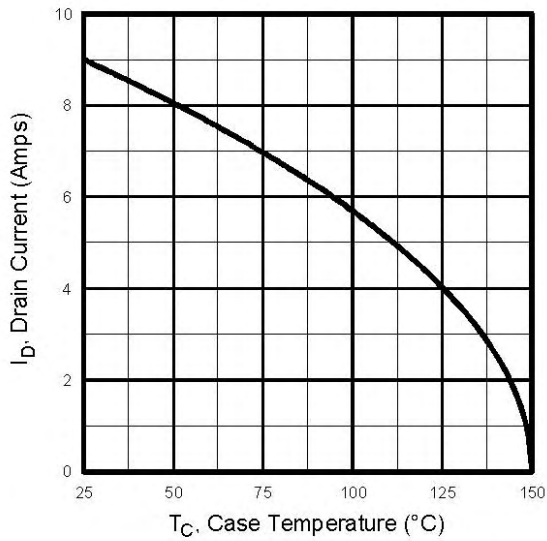
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



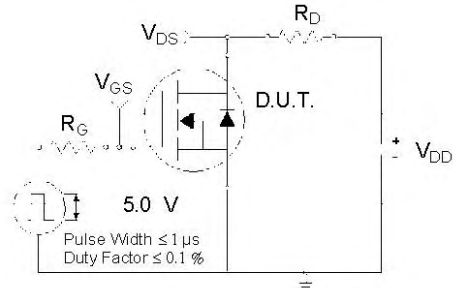
**Fig 7.** Typical Source-Drain Diode Forward Voltage



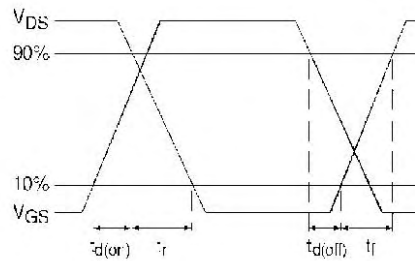
**Fig 8.** Maximum Safe Operating Area



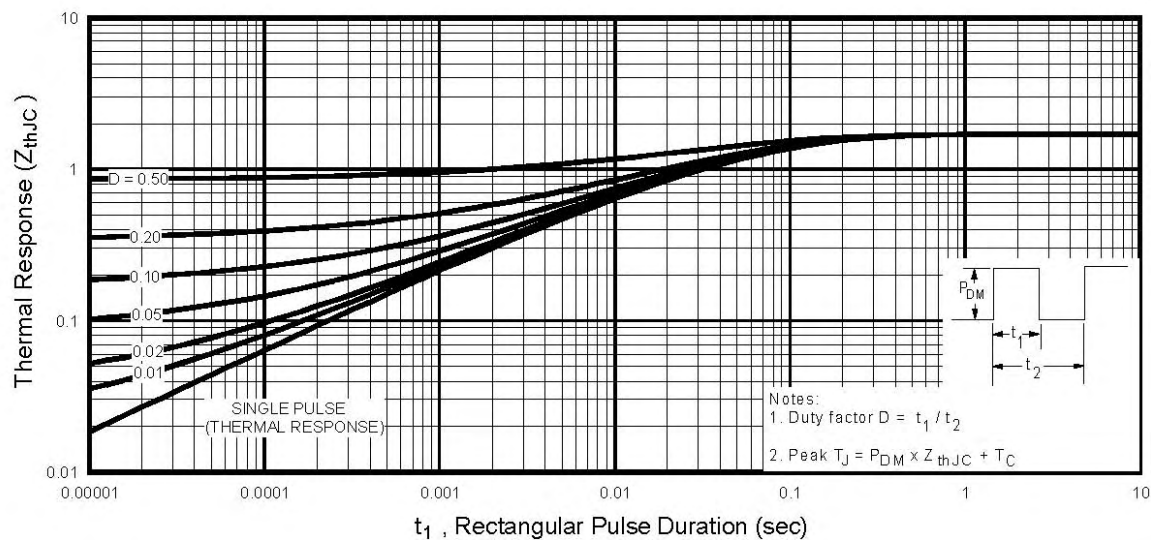
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



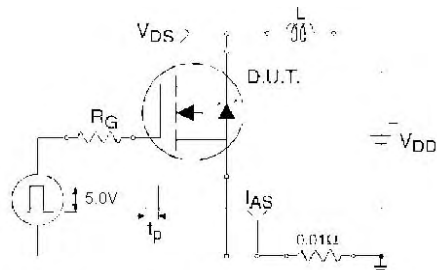
**Fig 10b.** Switching Time Waveforms



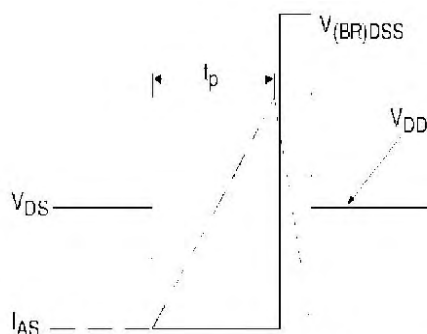
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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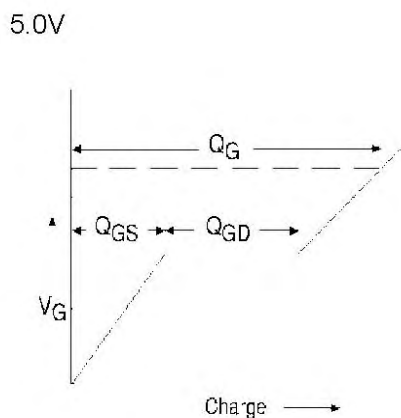
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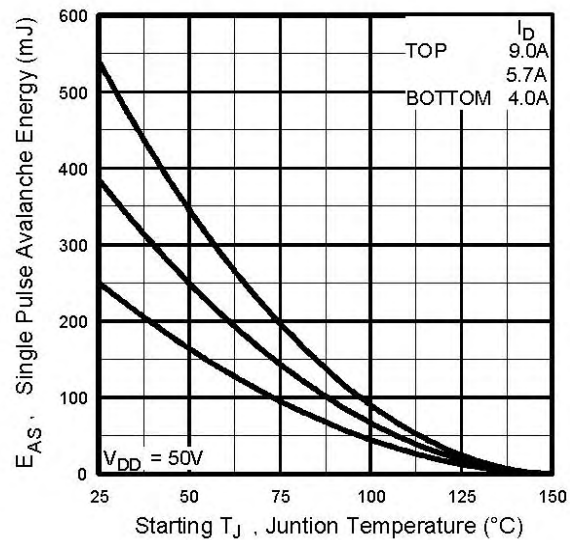
**Fig 12a.** Unclamped Inductive Test Circuit



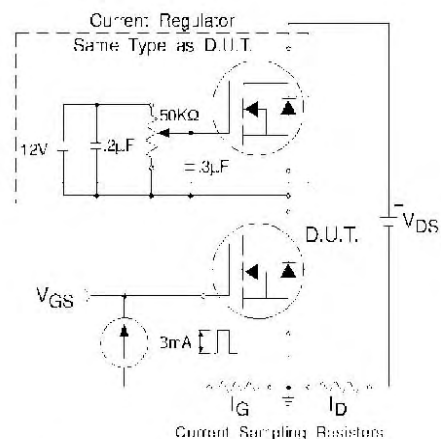
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform



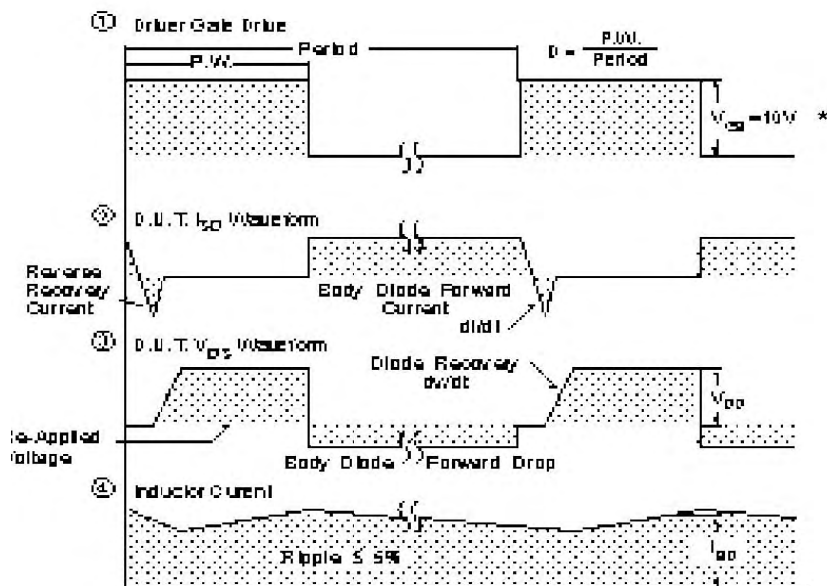
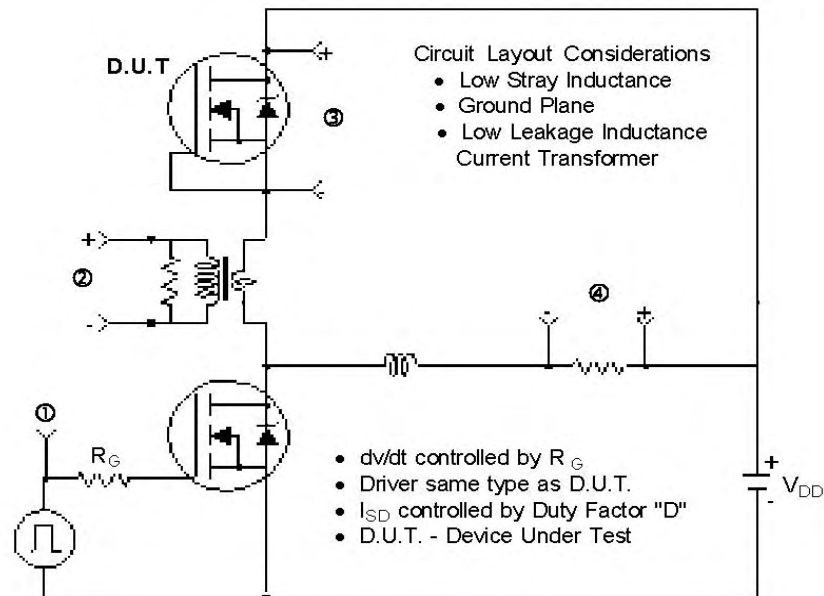
**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

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### Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

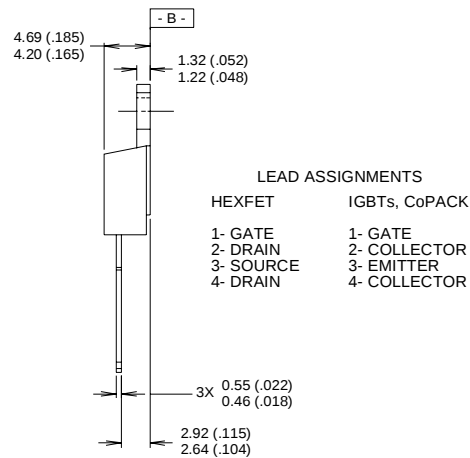
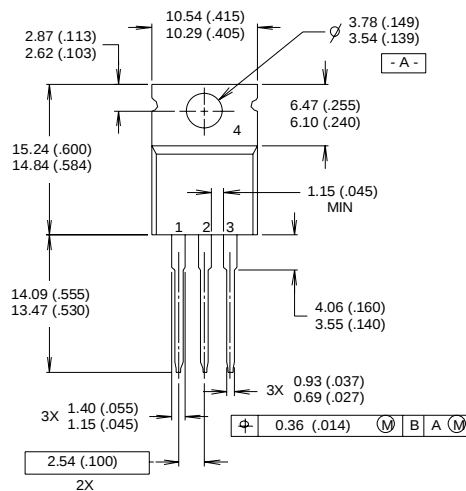
**Fig 14.** For N-Channel HEXFETS

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## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



| LEAD ASSIGNMENTS |               |
|------------------|---------------|
| HEXFET           | IGBTs, CoPACK |
| 1- GATE          | 1- GATE       |
| 2- DRAIN         | 2- COLLECTOR  |
| 3- SOURCE        | 3- EMITTER    |
| 4- DRAIN         | 4- COLLECTOR  |

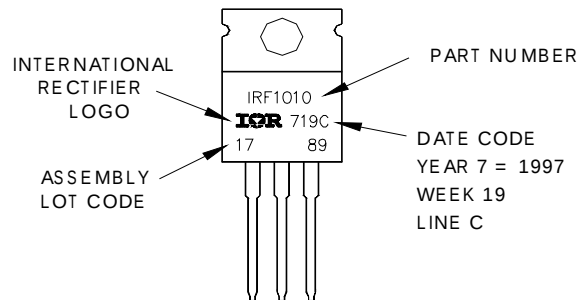
### NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
LOT CODE 1789  
ASSEMBLED ON WW 19, 1997  
IN THE ASSEMBLY LINE "C"

**Note:** "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.

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**IR** Rectifier

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